## Reexamination 09/248,111 NAKANO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1

Application/Control No.

SHAWN AN 2621

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

				Old I ALE III DO O O III E III O	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,256,346 B1	07-2001	Yamaguchi et al.	375/240.12
*	В	US-6,195,391 B1	02-2001	Hancock et al.	375/240.24
	O	US-5,694,171	12-1997	Katto, Jiro	375/240.03
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

TOREIGN PATERT BOOGMENTS								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Q							
	R							
	s							
	т							

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.